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Application No.	09/954,526	Prepared by	A. Agustín
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a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

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FOREIGN PATENT DOCUMENTS

	country	document number	publication date	name of patentee or applicant	translation y/n
	EP	0 254 644 A2	1/27/88	Fairchild Semiconductor Corporation	Y
	EP	0 923 050 A2	6/16/99	Affymetrix, Inc.	Y

OTHER DOCUMENTS (including Author (in CAPS), Title, Publication Date, Pages, etc.)

	EP Search Report for application EP 00 31 0774 (U.S. Counterparts 09/454,526; 09/455,304 and 09/456,105) dated July 18, 2003.